

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Group Art Unit: To Be Assigned  
Examiner: To Be Assigned

In re CONTINUATION PATENT APPLICATION of

Applicant(s)	:	Hidetaka KODAMA et al	)	
Appln. No.	:	To Be Assigned	)	
Filed	:	Concurrently (As A Continuation of Application No. 09/718,620, filed November 24, 2000	)	<b>INFORMATION DISCLOSURE STATEMENT</b>
For	:	LIQUID-CRYSTAL DISPLAY DRIVING CIRCUIT AND METHOD	)	
Atty. Dkt.	:	MAE 185 D1 C1	)	

Mail Stop: Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

The Examiner is respectfully requested to consult related copending application serial number 09/718,620, filed on November 24, 2000, for which priority under 35 U.S.C. §120 has been relied upon, for copies of the documents listed on the attached PTO-892 forms, which have been previously submitted therein (37 C.F.R. §1.98(d)).

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the document submitted. Consideration of the previously submitted documents is respectfully requested.

Respectfully submitted,



Phillip G. Avruch (Reg. No. 46,076)  
RABIN & BERDO, P.C.  
Telephone: 202-371-8976  
Telefax: 202-408-0924  
Customer No. 23995

August 29, 2003

Date

FEE ENCLOSED: \$ 750.00  
Please charge any further  
fee to our Deposit Account  
No. 18-0002

**Notice of References Cited**

Application/Control No.	09/718,620	Applicant(s)/Patent Under Reexamination
Examiner	Art Unit FRANCIS NGUYEN	KODAMA ET AL. 2674

Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,243,062	06-2001	den Boer et al.	345/91
B	US-6,172,663	01-2001	Okada et al.	345/96
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application No. 09/070,244	Applicant(s) Hidekata et al.	
		Examiner Wendell A. Peete, Jr.	Group Art Unit 2774	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
A	5,610,628	3/11/97	Yamamoto et al.	345	100
B	5,585,815	12/17/96	Nakashima et al.	345	100
C	5,844,535	12/1/98	Itoh et al.	345	92
D	3,654,606	4/4/72	Marlowe et al.	340	825.79
E	4,870,396	9/26/89	Shields	345	90
F					
G					
H					
I					
J					
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
N						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
U		
V		
W		
X		

<b>Notice of References Cited</b>			Application No.	Applicant(s)		
			09/718,620	HIDETAKA KODAIRA ET AL.		
			Examiner FRANCES NGUYEN	Group Art Unit 2674		
			Page 1 of 1			
U.S. PATENT DOCUMENTS						
*	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	
A	5,748,165	5/05/98	KUBOTA ET AL.	345	96	
B	6,166,725	12/26/00	ISAMI ET AL.	345	209	
C	5,949,396	7/30/97	LEE	345	87	
D	6,049,321	4/11/00	SASAKI	345	99	
E						
F						
G						
H						
I						
J						
K						
L						
M						
FOREIGN PATENT DOCUMENTS						
*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
N						
O						
P						
Q						
R						
S						
T						
NON-PATENT DOCUMENTS						
*	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)					DATE
U						
V						
W						
X						

\* A copy of this reference is not being furnished with this Office action.  
 (See Manual of Patent Examining Procedure, Section 707.05(a).)